

Search Notes**Application/Control No.**

10/069,161

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	216	12/6/2005	BQN
370	323	12/6/2005	BQN
370	462	12/6/2005	BQN
364	474.15	12/6/2005	BQN
370	236.1	12/6/2005	BQN
370	229	12/6/2005	BQN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-GPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB), see more on search history.	12/6/2005	BQN
Consulted with Wellington Chin	12/5/2005	BQN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner